

Notice of References Cited	Application/Control No. 10/525,922	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Naghmeh Mehrpour	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0207555	09-2005	Lee et al.	379/207.16
*	B	US-6,603,844	08-2003	Chavez et al.	379/114.13
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	M	US-			

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NON-PATENT DOCUMENTS

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